### **General Description**

The SJD015N2200 uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 10V. This device is suitable for use as a wide variety of applications.

#### **Features**

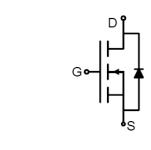
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

### **Application**

- Power switching application
- Hard switched and high frequency circuits

### **Key Performance Parametes**

Parameter	Value	Unit
V <sub>DS</sub>	150	V
R <sub>DS(ON)_TYP</sub>	216	mΩ
I <sub>D</sub>	10	Α
Q <sub>G</sub>	16	nC







**Schematic Diagram** 

TO-252(DPAK) top view

### **Package Marking and Ordering Information**

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJD015N2200	D015N2200	TO-252	Tape	\	\	2500 Pcs

### Table 1. Absolute Maximum Ratings (T<sub>C</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	150	V
V <sub>GS</sub>	Gate-Source Voltage (V <sub>DS</sub> =0V)	±20	V
1-	Drain Current-Continuous(Tc=25℃)	10	А
l <sub>D</sub>	Drain Current-Continuous(T <sub>C</sub> =100℃)	6.2	А
I <sub>DM</sub> (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	40	А
D	Maximum Power Dissipation(T <sub>C</sub> =25°ℂ)	60	W
P <sub>D</sub>	Maximum Power Dissipation(Tc=100°C)	23.8	W
E <sub>AS</sub>	Avalanche energy (Note 2)	9	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	°C

#### Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
R <sub>θ</sub> JC	Thermal Resistance, Junction-to-Case		2.1	°C/W



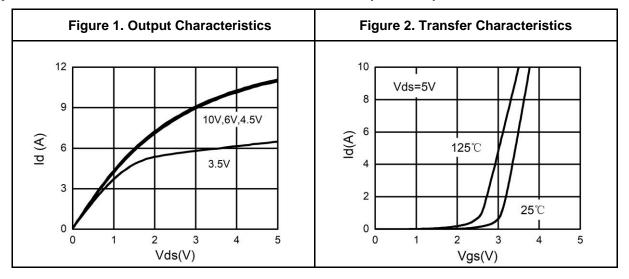
Table 3. Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

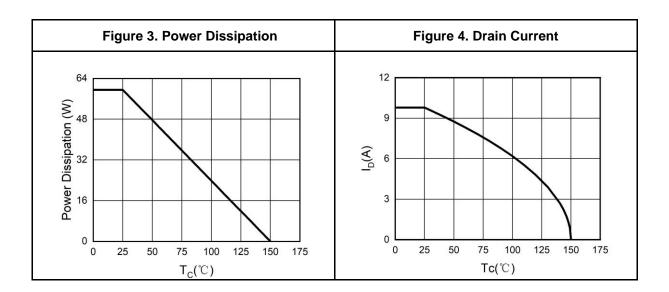
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	150			V
	Zara Oata Valta va Dusin Oussant	V <sub>DS</sub> =150V, V <sub>GS</sub> =0V T <sub>J</sub> =25℃			1	μΑ
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =150V, V <sub>GS</sub> =0V T <sub>J</sub> =125℃			100	μΑ
Igss	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	1		3	V
<b>g</b> FS	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =3A		8		S
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =3A T <sub>J</sub> =25℃		216	259	mΩ
Dynamic Charac	teristics					
Ciss	Input Capacitance			733		pF
Coss	Output Capacitance	V <sub>DS</sub> =75V,V <sub>GS</sub> =0V, f=1.0MHz		13.5		pF
Crss	Reverse Transfer Capacitance			5		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		1.4		Ω
Switching Param	neters					
t <sub>d(on)</sub>	Turn-on Delay Time			9		nS
tr	Turn-on Rise Time	V <sub>GS</sub> =10V, V <sub>DS</sub> =75V,		11		nS
t <sub>d(off)</sub>	Turn-Off Delay Time	R <sub>L</sub> =25Ω, R <sub>GEN</sub> =6Ω		24		nS
t <sub>f</sub>	Turn-Off Fall Time			8		nS
$Q_g$	Total Gate Charge			16		nC
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =75V, I <sub>D</sub> =3A		2.1		nC
$Q_{gd}$	Gate-Drain Charge			6.4		nC
Source-Drain Did	ode Characteristics			•		
I <sub>SD</sub>	Source-Drain Current (Body Diode)				10	А
$V_{SD}$	Forward on Voltage (Note 3)	V <sub>GS</sub> =0V, I <sub>S</sub> =3A			1.2	V

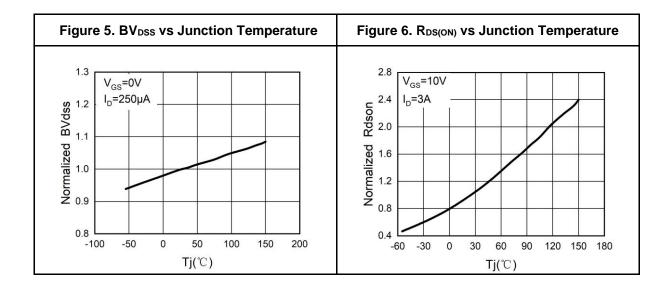
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature. Notes 2.E<sub>AS</sub> condition:  $T_J$ =25°C, $V_DD$ =40V, $V_G$ =10V, Rg=25 $\Omega$ , L=0.5mH.

Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

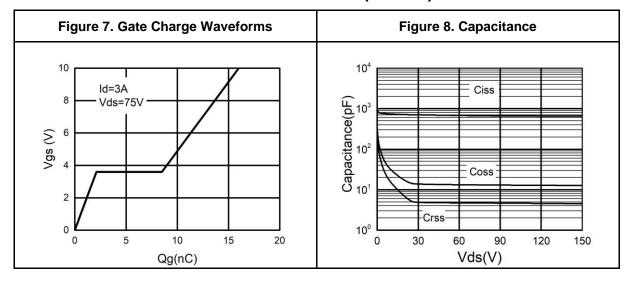
### **Typical Electrical And Thermal Characteristics (Curves)**

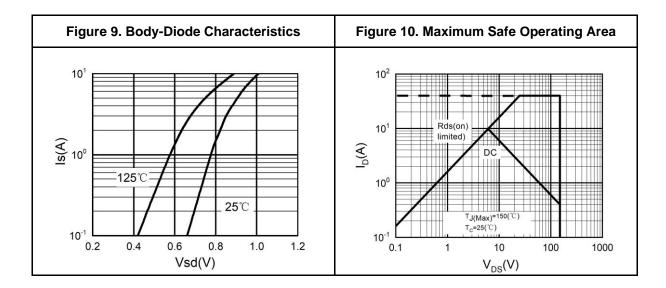




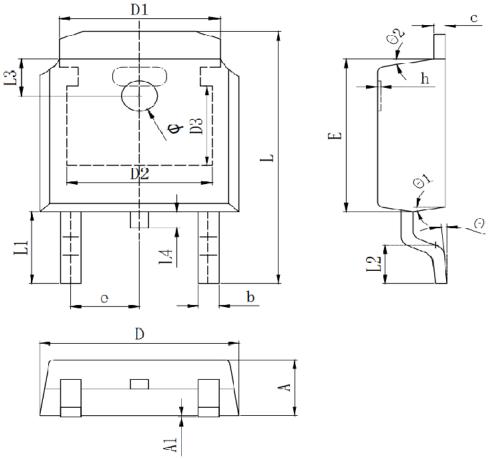


### **Typical Electrical And Thermal Characteristics (Curves)**





# **TO-252 Package Information**



Symbol		Dimensions In Millimeters		
Symbol	Min.	Тур.	Max.	
А	2.200	2.300	2.400	
A1	0.000		0.127	
b	0.640	0.690	0.740	
c(电镀后)	0.460	0.520	0.580	
D	6.500	6.600	6.700	
D1		5.334 REF		
D2		4.826 REF		
D3	3.166 REF			
E	6.000	6.100	6.200	
е		2.286 TYP		
h	0.000	0.100	0.200	
L	9.900	10.100	10.300	
L1		2.888 REF		
L2	1.400	1.550	1.700	
L3		1.600 REF		
L4	0.600	0.800	1.000	
Ф	1.100	1.200	1.300	
θ	0°		8°	
θ1		9° TYP		
θ2	9° TYP			



### **Attention**

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor

The performances and characteristics of this product in the independent testing state are displayed in this document. Wuxi Shangjia Semiconductor can't guarantee of the performances and characteristics of this described product that mounted in the customer's products or equipments as same as that in the independent testing state. So the customer should evaluate and test devices mounted in the customer's products or equipments.

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